

Search Notes

Application/Control No.

10/735,425

Examiner

M. Lee

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2622

SEARCHED

Class	Subclass	Date	Examiner
348	188, 187, 180, 181, 185, 189	2/5/2007	ML
	190, 191		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	2/5/2007	ML